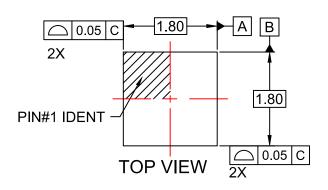
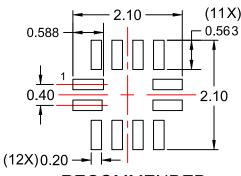
UQFN12 1.8x1.8, 0.4P CASE 523BE ISSUE O

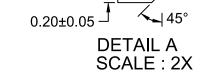
DATE 31 OCT 2016





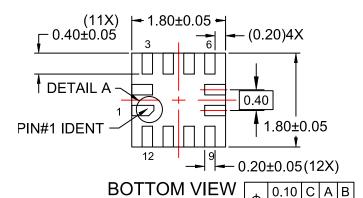
0.10 C 0.50±0.05 0.08 C 0.025±0.025 SEATING C PLANE

RECOMMENDED LAND PATTERN



0.425±0.05

SIDE VIEW



NOTES:

- A. PACKAGE DOES NOT CONFORM TO ANY JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

PACKAGE \
EDGE \

LEAD OPTION 1 SCALE : 2X LEAD OPTION 2 SCALE : 2X

0.05

DOCUMENT NUMBER: 98AON13708G

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DESCRIPTION: UQFN12 1.8x1.8, 0.4P

PAGE 1 OF 1

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